

## 200-V Half-Bridge Driver

### Features

- $I_{O+} / I_{O-}$  of 290 mA / 600 mA typical gate current
- Gate drive voltage up to 20 V per channel
- Independent under-voltage lockout for  $V_{CC}$ ,  $V_{BS}$
- 3.3 V, 5 V, 15 V input logic compatible
- Tolerant to negative transient voltage
- Designed for use with bootstrap power supplies
- Cross-conduction prevention logic
- Matched propagation delay for both channels
- Internal set dead-time
- High-side output in phase with HIN input
- Low-side output out of phase with LIN input
- -40 °C to 125 °C operating range
- 2 kV HBM ESD
- RoHS compliant

### Description

The IRS2007S is a high voltage, high speed power MOSFET driver with dependent high and low side referenced output channels. Proprietary HVIC and latch immune CMOS technologies enable ruggedized monolithic construction. The logic input is compatible with standard CMOS or LSTTL output, down to 3.3 V logic. The output drivers feature a high pulse current buffer stage designed for minimum driver cross-conduction. The floating channel can be used to drive an N-channel power MOSFET or IGBT in the high side configuration which operates up to 200 V. Propagation delays are matched to simplify the HVIC's use in high frequency applications.

### Product Summary

$V_{\text{OFFSET}}$	$\leq 200 \text{ V}$
$V_{\text{OUT}}$	10 V – 20 V
$I_{O+} \& I_{O-} \text{ (typ.)}$	290 mA & 600 mA
$t_{\text{ON}} \& t_{\text{OFF}} \text{ (typ.)}$	160 ns & 150 ns
Dead-time (typ.)	520 ns

### Package Options



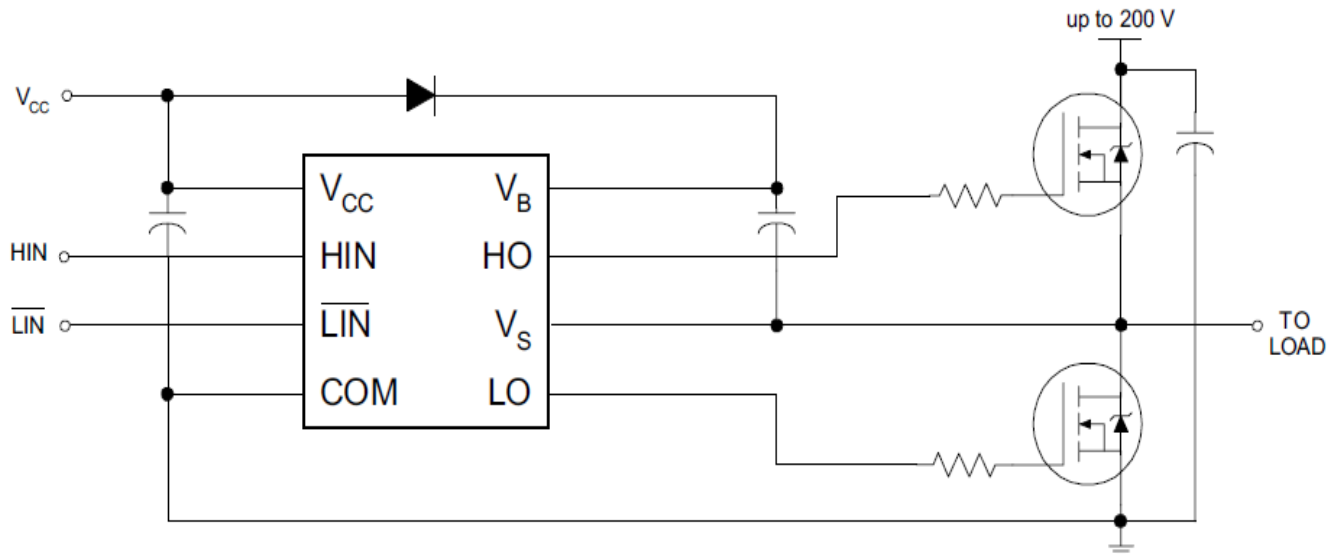
8-Lead SOIC

### Typical Applications

- Battery operated power tools
- Battery operated garden equipment
- Light electric vehicles (e-bikes, e-scooters, e-toys)
- Wireless Charging
- Other general battery driven applications

Base Part Number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
IRS2007SPBF	8-Lead SOIC	Tube/Bulk	95	IRS2007SPBF
		Tape and Reel	2500	IRS2007STRPBF

## Typical Connection Diagram



(Refer to Lead Assignments for correct pin configuration). This diagram shows electrical connections only. Please refer to our Application Notes & Design Tips for proper circuit board layout.

## Absolute Maximum Ratings

Absolute maximum ratings indicate sustained limits beyond which damage to the device may occur. All voltage parameters are absolute voltages referenced to COM unless otherwise stated in the table. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions.

Symbol	Definition		Min.	Max.	Units
$V_{CC}$	Low side supply voltage		-0.3	25 <sup>†</sup>	V
$V_{IN}$	Logic input voltage ( $HIN$ & $\overline{LIN}$ )		COM - 0.3	$V_{CC} + 0.3$	
$V_B$	High-side floating well supply voltage		-0.3	225	
$V_S$	High-side floating well supply return voltage		$V_B - 25$	$V_B + 0.3$	
$V_{HO}$	Floating gate drive output voltage		$V_S - 0.3$	$V_B + 0.3$	
$V_{LO}$	Low-side output voltage		COM - 0.3	$V_{CC} + 0.3$	
COM	Power ground		$V_{CC} - 25$	$V_{CC} + 0.3$	
$dV_S/dt$	Allowable $V_S$ offset supply transient relative to COM		—	50	V/ns
$P_D$	Package power dissipation @ $T_A \leq +25\text{ }^\circ\text{C}$	8-Lead SOIC	—	0.625	W
$R_{thJA}$	Thermal resistance, junction to ambient	8-Lead SOIC	—	200	$^\circ\text{C/W}$
$T_J$	Junction temperature		—	150	$^\circ\text{C}$
$T_S$	Storage temperature		-55	150	
$T_L$	Lead temperature (soldering, 10 seconds)		—	300	

† All supplies are tested at 25 V.

## Recommended Operating Conditions

For proper operation, the device should be used within the recommended conditions. All voltage parameters are absolute voltages referenced to COM unless otherwise stated in the table. The offset rating is tested with supplies of  $(V_{CC} - COM) = (V_B - V_S) = 15\text{ V}$ .

Symbol	Definition	Min	Max	Units
$V_{CC}$	Low-side supply voltage	10	20	V
$V_{IN}$	Logic input voltage( $HIN$ & $\overline{LIN}$ )	0	$V_{CC}$	
$V_B$	High-side floating well supply voltage	$V_S + 10$	$V_S + 20$	
$V_S$	High-side floating well supply offset voltage <sup>†</sup>	COM - 8 <sup>†</sup>	200	
$V_{HO}$	Floating gate drive output voltage	$V_S$	$V_B$	
$V_{LO}$	Low-side output voltage	COM	$V_{CC}$	
$T_A$	Ambient temperature	-40	125	$^\circ\text{C}$

† Logic operation for  $V_S$  of  $-8\text{ V}$  to  $200\text{ V}$ . Logic state held for  $V_S$  of  $-8\text{ V}$  to  $-V_{BS}$ . Please refer to Design Tip DT97-3 for more details.

### Static Electrical Characteristics

( $V_{CC} - COM$ ) = ( $V_B - V_S$ ) = 15V.  $T_A = 25^\circ\text{C}$  unless otherwise specified. The  $V_{IN}$  and  $I_{IN}$  parameters are referenced to COM. The  $V_O$  and  $I_O$  parameters are referenced to respective  $V_S$  and COM and are applicable to the respective output leads HO or LO. The  $V_{CCUV}$  parameters are referenced to COM. The  $V_{BSUV}$  parameters referenced to  $V_S$ . Output Current Direction is defined as positive out of the pin and negative into the pin

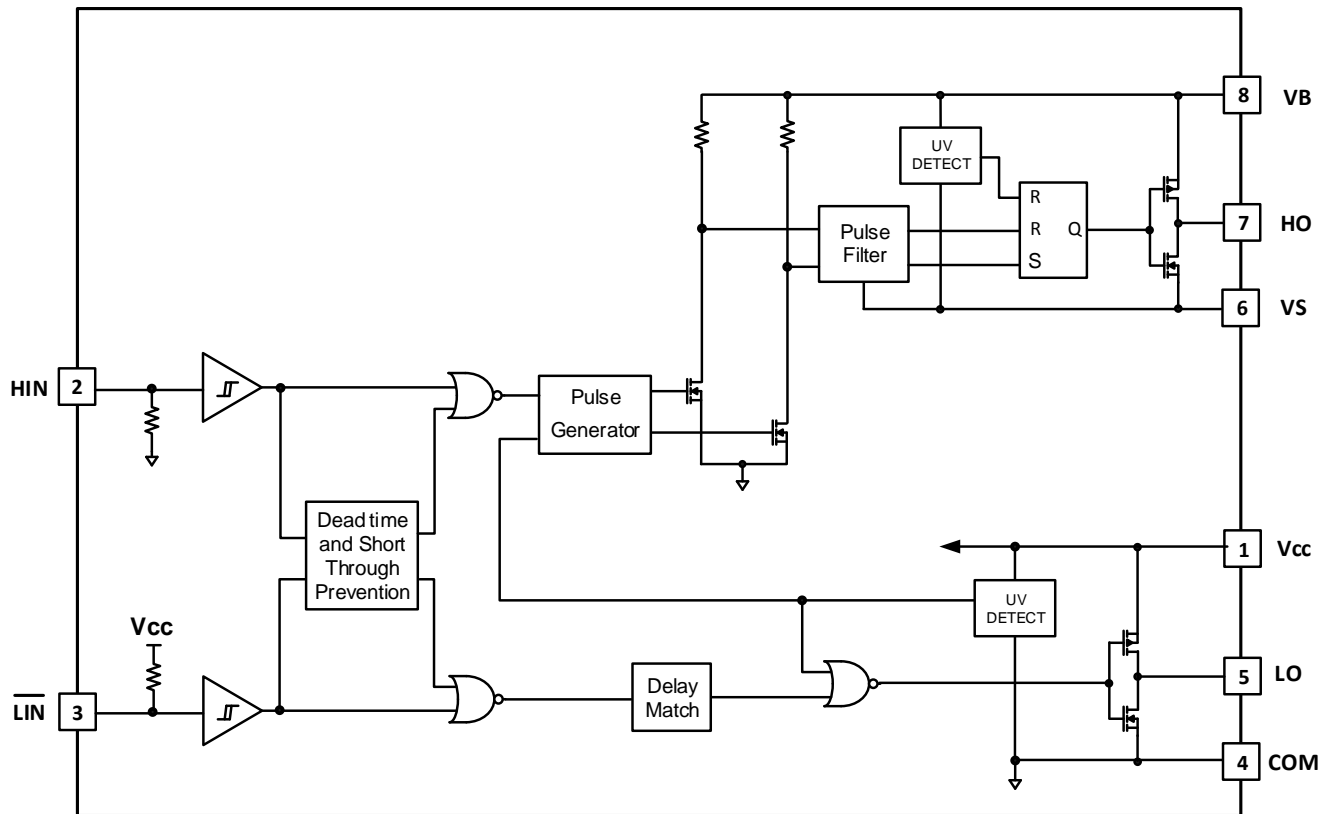
Symbol	Definition	Min.	Typ.	Max.	Units	Test Conditions
$V_{BSUV+}$	$V_{BS}$ supply under voltage positive threshold	8.0	8.9	9.8	V	
$V_{BSUV-}$	$V_{BS}$ supply under voltage negative threshold	7.4	8.2	9		
$V_{BSUVHY}$	$V_{BS}$ supply under voltage hysteresis	—	0.7	—		
$V_{CCUV+}$	$V_{CC}$ supply under voltage positive threshold	8.0	8.9	9.8		
$V_{CCUV-}$	$V_{CC}$ supply under voltage negative threshold	7.4	8.2	9		
$V_{CCUVHY}$	$V_{CC}$ supply under voltage hysteresis	—	0.7	—		
$I_{LK}$	High-side floating well offset supply leakage	—	—	50	$\mu\text{A}$	$V_B = V_S = 200\text{ V}$
$I_{QBS}$	Quiescent $V_{BS}$ supply current	—	45	75		All inputs are in the off state
$I_{QCC}$	Quiescent $V_{CC}$ supply current	—	300	520		
$V_{OH}$	High level output voltage drop, $V_{BIAS} - V_O$	—	0.05	0.2	V	$I_O = 2\text{ mA}$
$V_{OL}$	Low level output voltage drop, $V_O$	—	0.02	0.1		
$I_{O+}$	Output high short circuit pulsed current	200	290	—	mA	$V_O = 0\text{ V}$ , $V_{IN} = V_{IH}$ $PW \leq 10\text{ }\mu\text{s}$
$ I_{O-} $	Output low short circuit pulsed current	420	600	—		$V_O = 15\text{ V}$ , $V_{IN} = V_{IL}$ $PW \leq 10\text{ }\mu\text{s}$
$V_{IH}$	Logic "1" (HIN) & Logic "0" ( $\overline{LIN}$ ) input voltage	2.5	—	—	V	$V_{CC} = 10\text{ V} - 20\text{ V}$
$V_{IL}$	Logic "0" (HIN) & Logic "1" ( $\overline{LIN}$ ) input voltage	—	—	0.8		
$I_{IN+}$	Logic "1" Input bias current	—	3	10	$\mu\text{A}$	$HIN = 5\text{ V}$ $\overline{LIN} = 0\text{ V}$
$I_{IN-}$	Logic "0" Input bias current	—	—	5		$HIN = 0\text{ V}$ $\overline{LIN} = 5\text{ V}$

### Dynamic Electrical Characteristics

$V_{CC} = V_B = 15\text{ V}$ ,  $V_S = COM$ ,  $T_A = 25^\circ\text{C}$ , and  $C_L = 1000\text{ pF}$  unless otherwise specified.

Symbol	Definition	Min.	Typ.	Max.	Units	Test Conditions
$t_{ON}$	Turn-on propagation delay	—	160	220	ns	$V_S = 0\text{ V}$ or $200\text{ V}$
$t_{OFF}$	Turn-off propagation delay	—	150	220		
$t_R$	Turn-on rise time	—	70	170		
$t_F$	Turn-off fall time	—	30	90		
MT	Delay matching time ( $t_{ON}$ , $t_{OFF}$ )	—	—	50		
DT	Deadtime, LO turn-off to HO turn-on & HO turn-off to LO turn-on	400	520	650		
MDT	Deadtime matching = $ DT_{LO-HO} - DT_{HO-LO} $	—	—	30		

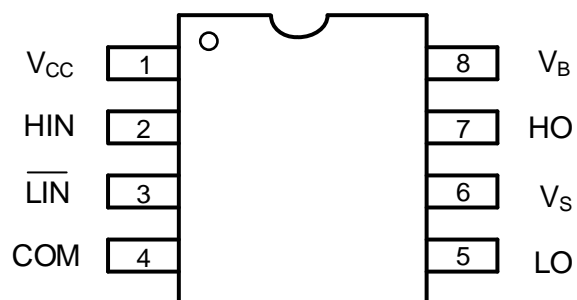
# Functional Block Diagram



## Lead Definitions

Symbol	Description
V <sub>CC</sub>	Low-side and logic supply voltage
V <sub>B</sub>	High-side gate drive floating supply
V <sub>S</sub>	High voltage floating supply return
HIN	Logic inputs for high-side gate driver output (HO), in phase
$\overline{\text{LIN}}$	Logic inputs for low-side gate driver output (LO), out of phase
HO	High-side driver output
LO	Low-side driver output
COM	Low-side gate drive return

## Lead Assignments



8-Lead SOIC

**IRS2007S**

## Application Information and Additional Details

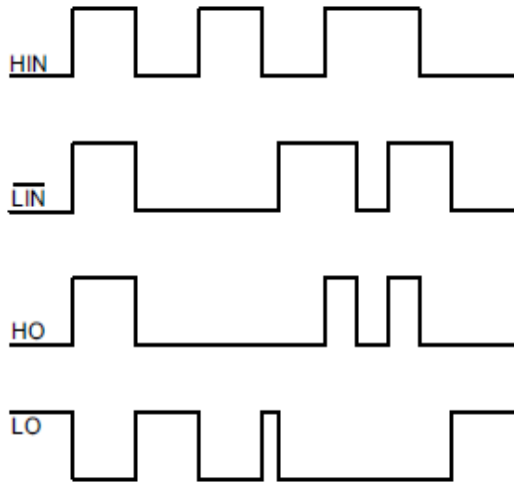


Figure 1. Input/Output Timing Diagram

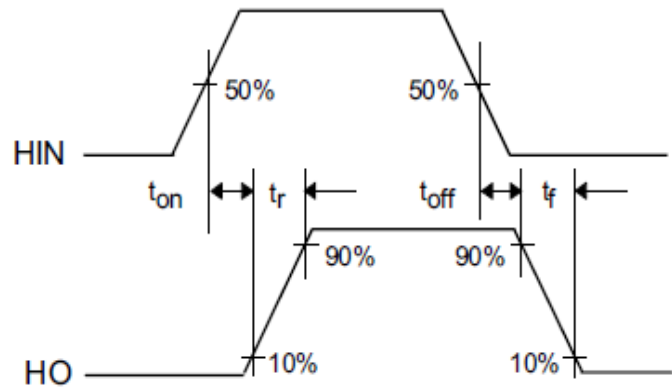
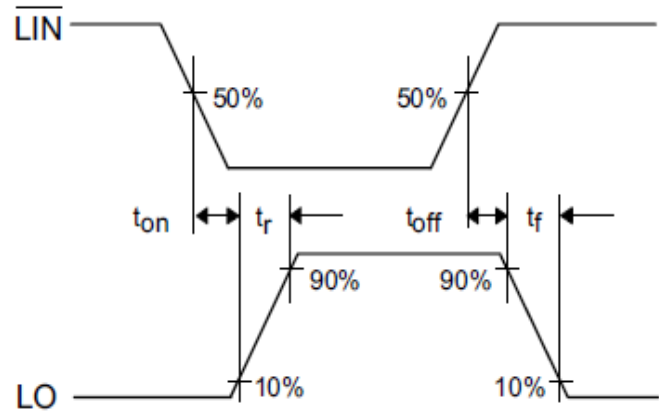


Figure 2. Switching Time Waveform Definitions

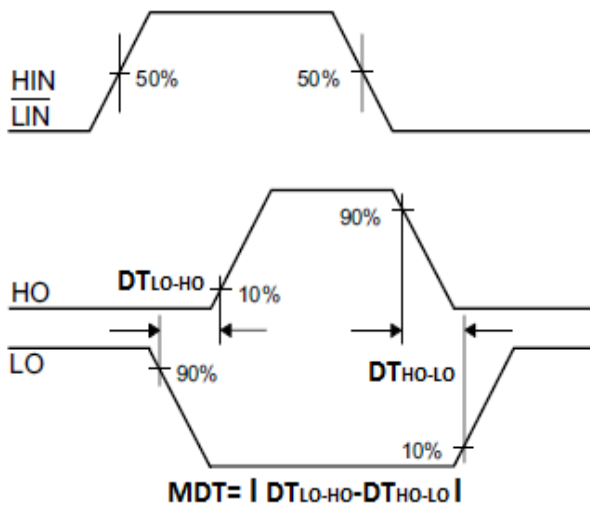
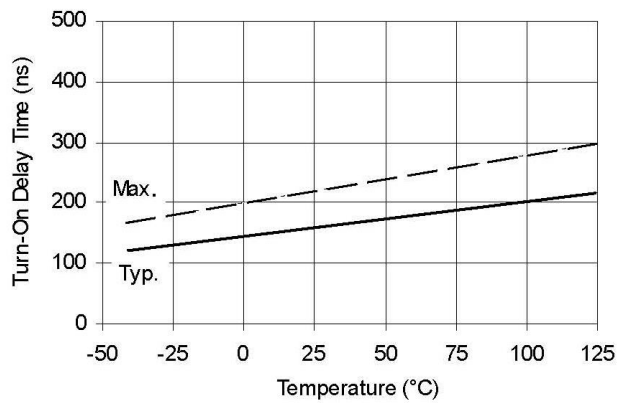
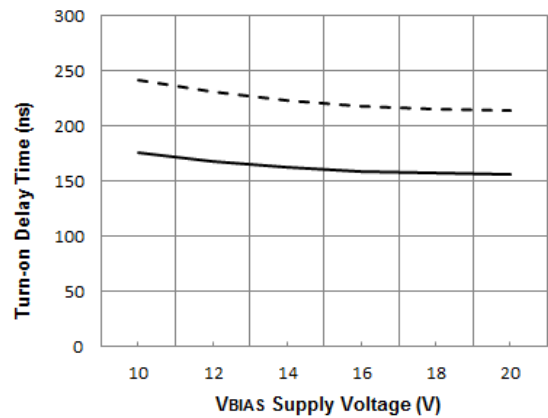


Figure 3. Deadtime Waveform Definitions

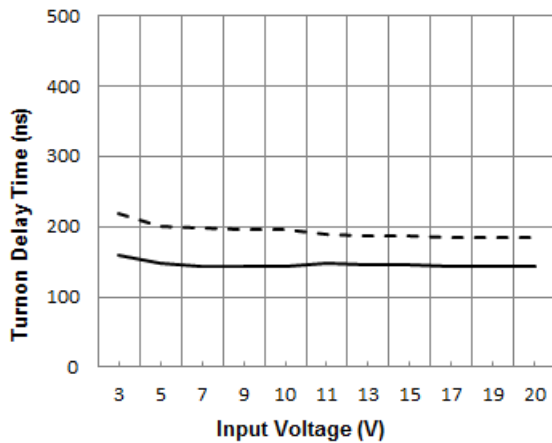
Parameters trend with different temperature and voltage bias. (Fig. 4 ~ Fig. 20)



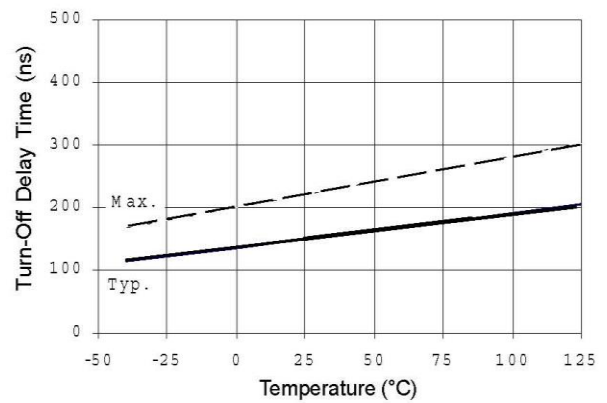
**Figure 4A. Turn-On Time vs. Temperature**



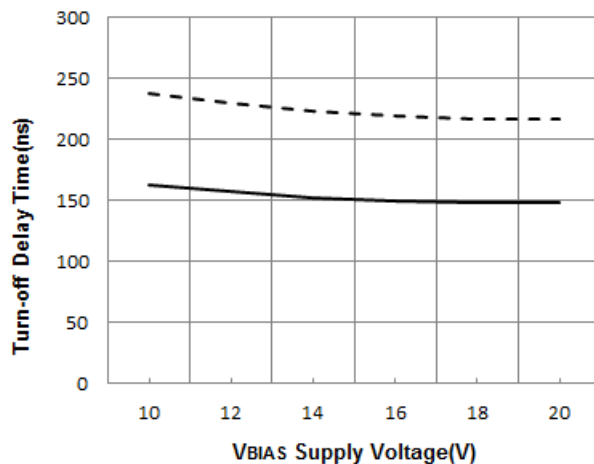
**Figure 4B. Turn-On Time vs. Supply Voltage**



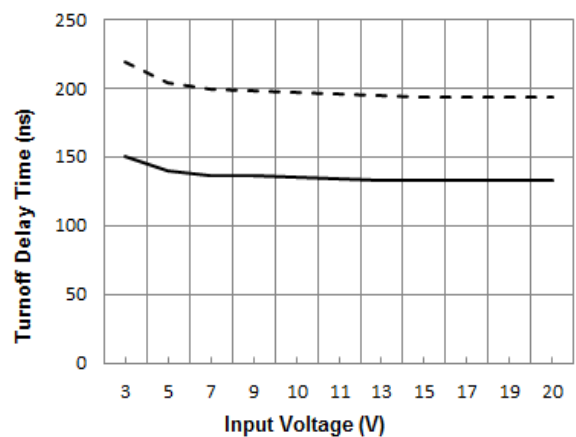
**Figure 4C. Turn-On Time vs. Input Voltage**



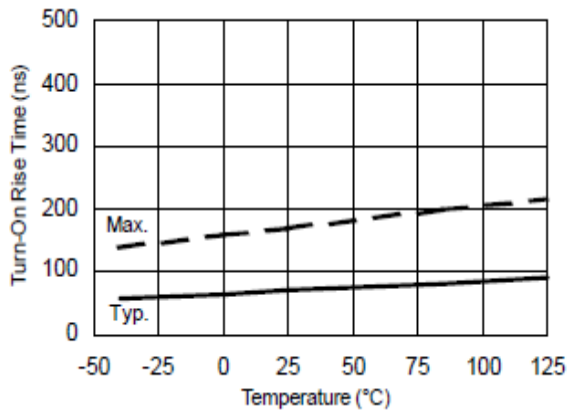
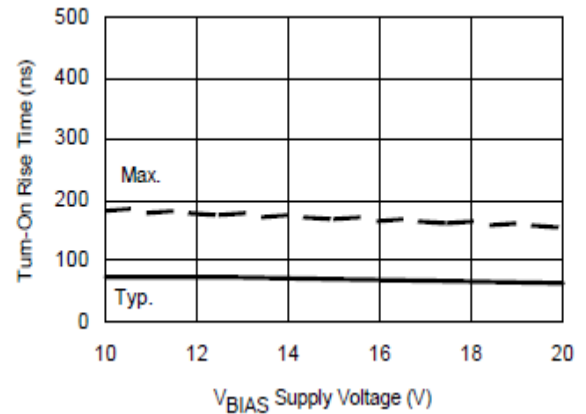
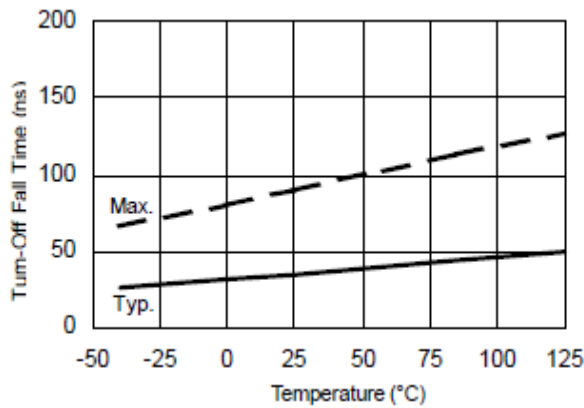
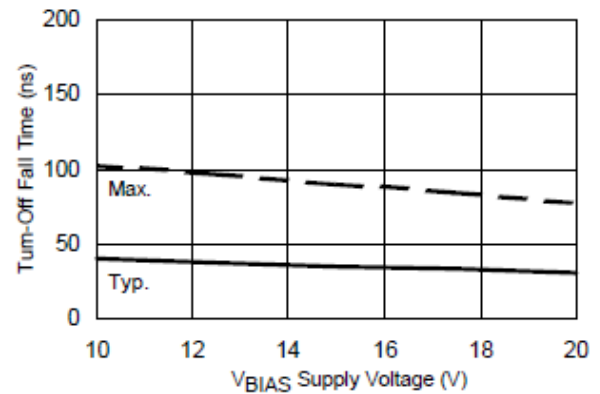
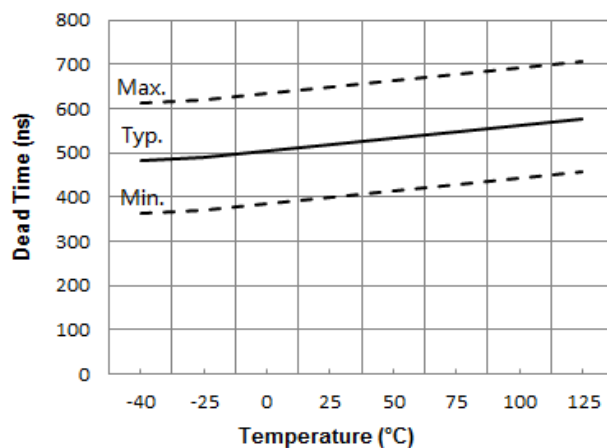
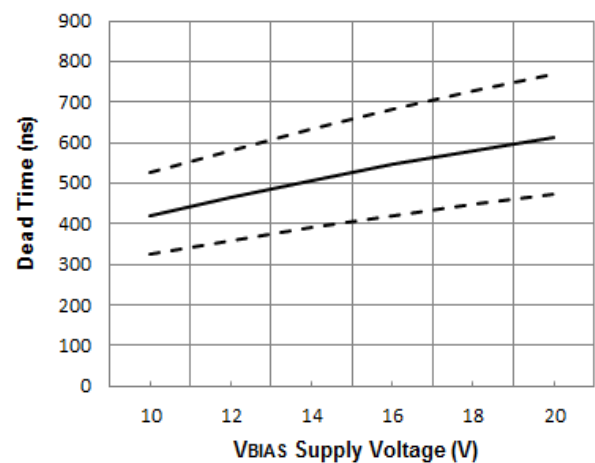
**Figure 5A. Turn-Off Time vs. Temperature**

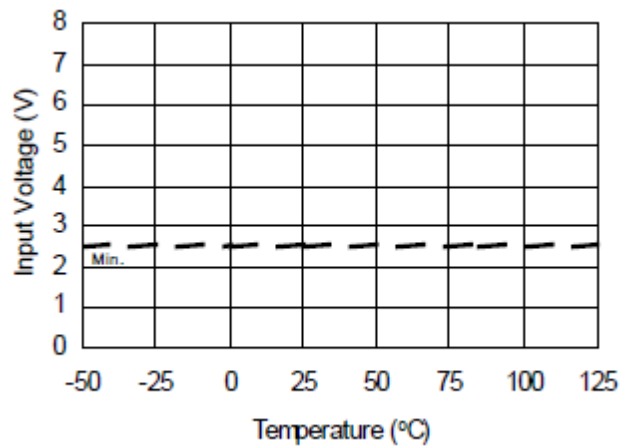


**Figure 5B. Turn-Off Time vs. Supply Voltage**

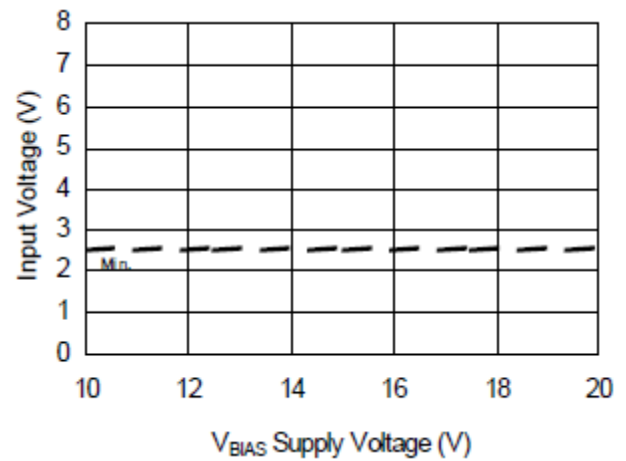


**Figure 5C. Turn-Off Time vs. Input Voltage**

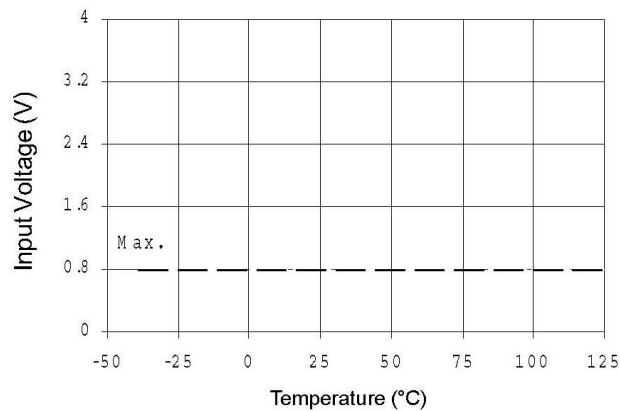

**Figure 6A. Turn-On Rise Time vs. Temperature**

**Figure 6B. Turn-On Rise Time vs. Voltage**

**Figure 7A. Turn-Off Fall Time vs. Temperature**

**Figure 7B. Turn-Off Fall Time vs. Voltage**

**Figure 8A. Deadtime vs. Temperature**

**Figure 8A. Deadtime vs. Supply Voltage**



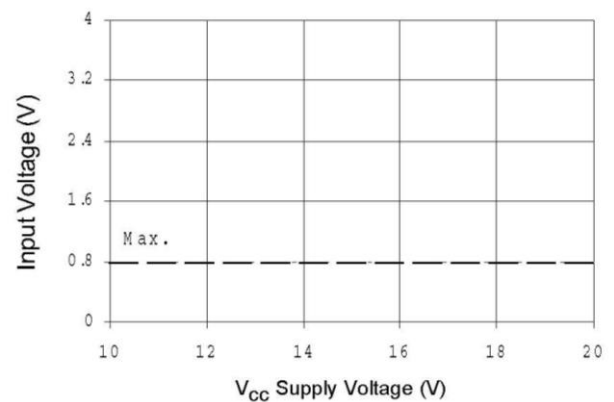
**Figure 9A. Logic "1"(HIN) & Logic "0"(LIN)  
Input Voltage vs. Temperature**



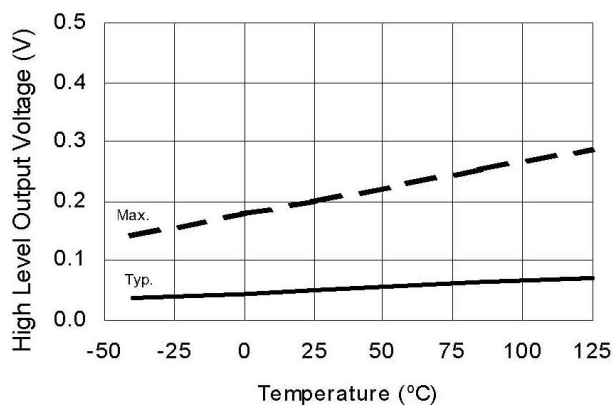
**Figure 9B. Logic "1"(HIN) & Logic "0"(LIN)  
Input Voltage vs. Supply Voltage**



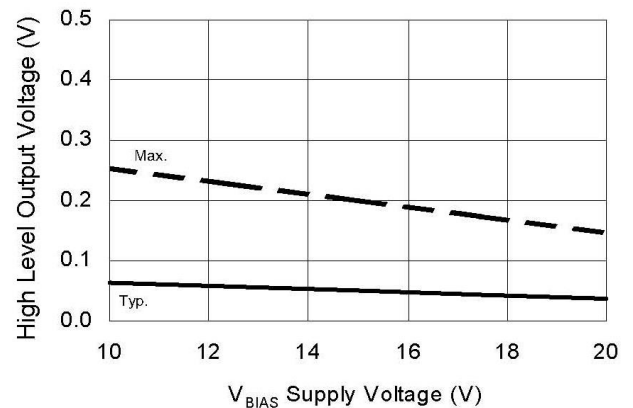
**Figure 10A. Logic "0"(HIN) & Logic "1"(LIN)  
Input Voltage vs. Temperature**



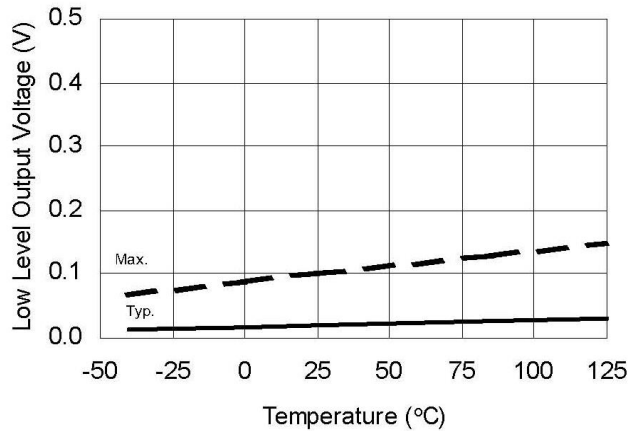
**Figure 10B. Logic "0"(HIN) & Logic "1"(LIN)  
Input Voltage vs. Supply Voltage**



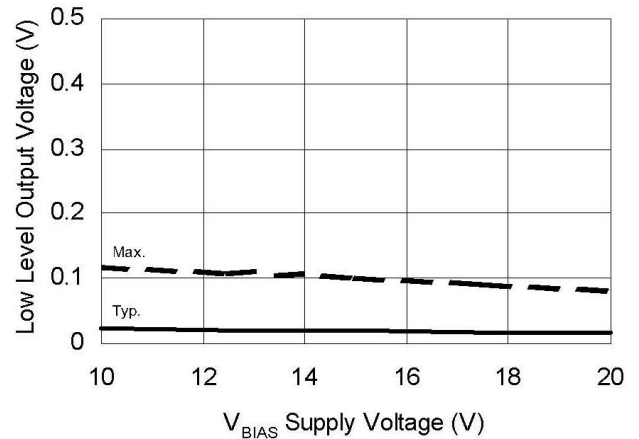
**Figure 11A. High Level Output Voltage vs. Temperature**



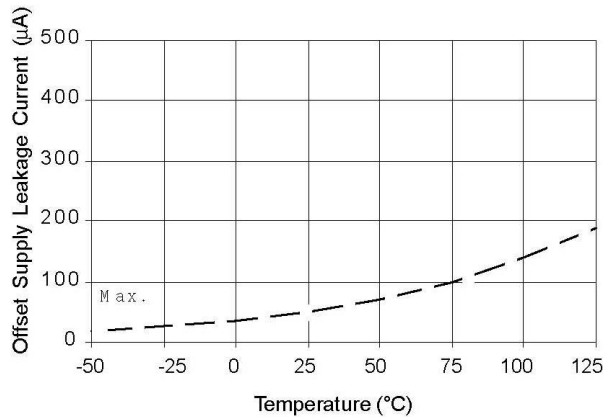
**Figure 11B. High Level Output Voltage  
vs. Supply Voltage**



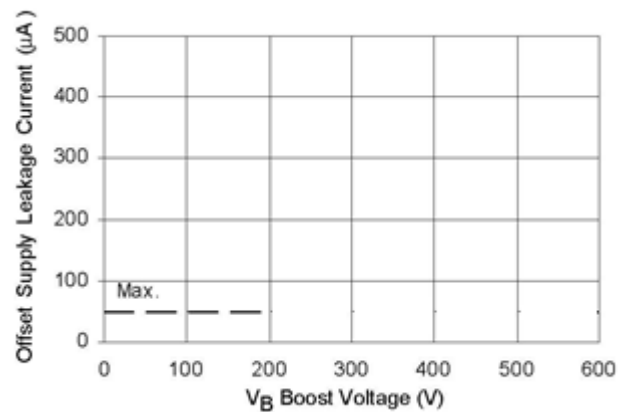
**Figure 12A. Low Level Output Voltage vs. Temperature**



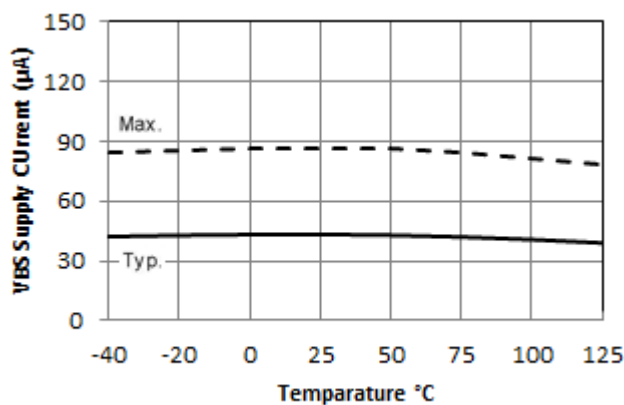
**Figure 12B. Low Level Output Voltage vs. Supply Voltage**



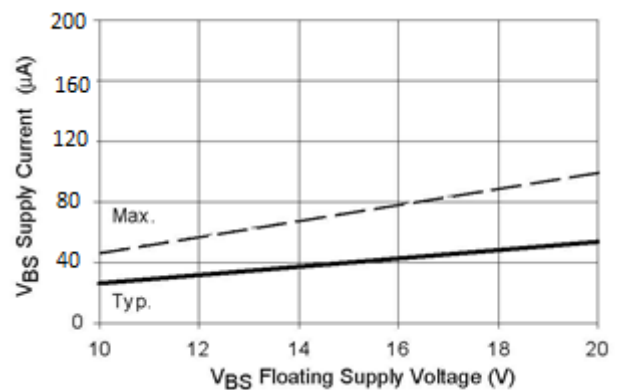
**Figure 13A. Offset Supply Current vs. Temperature**



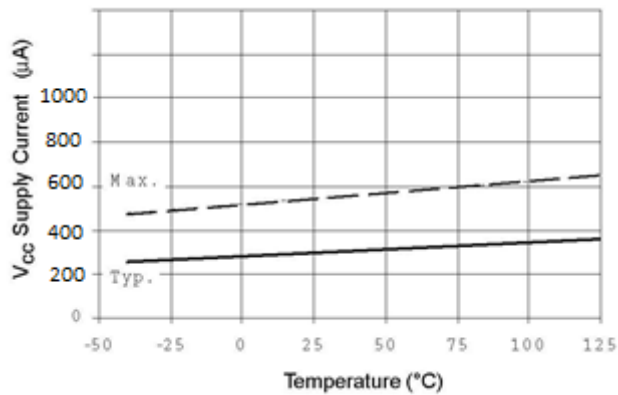
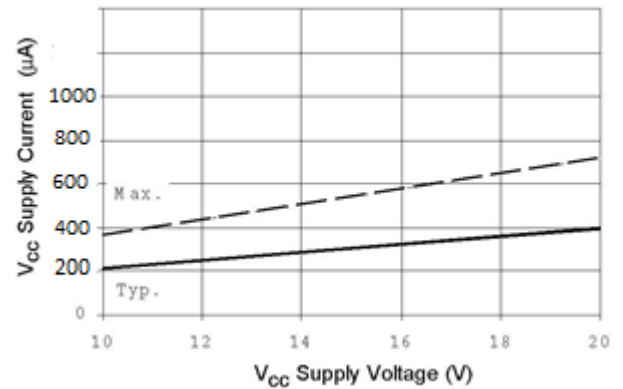
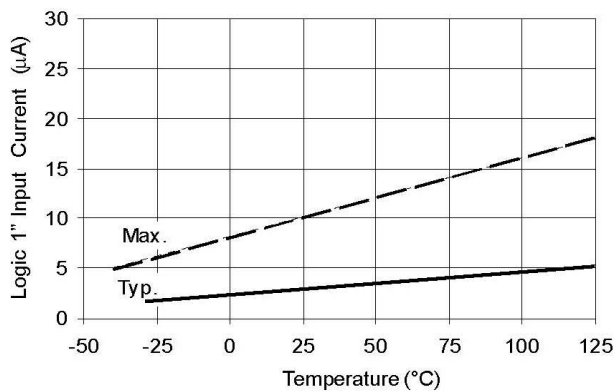
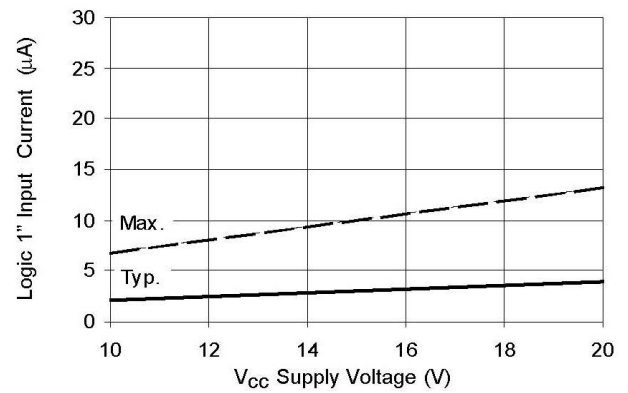
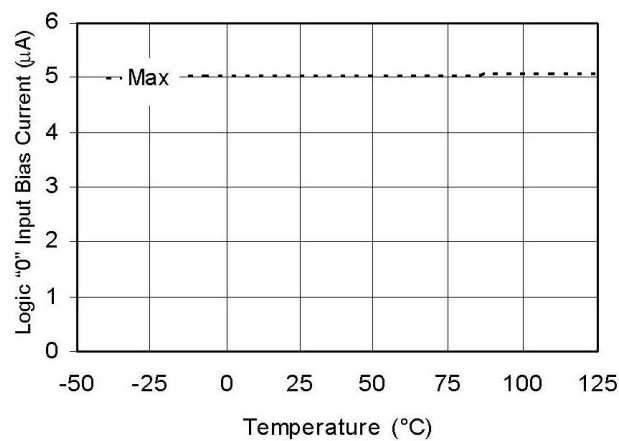
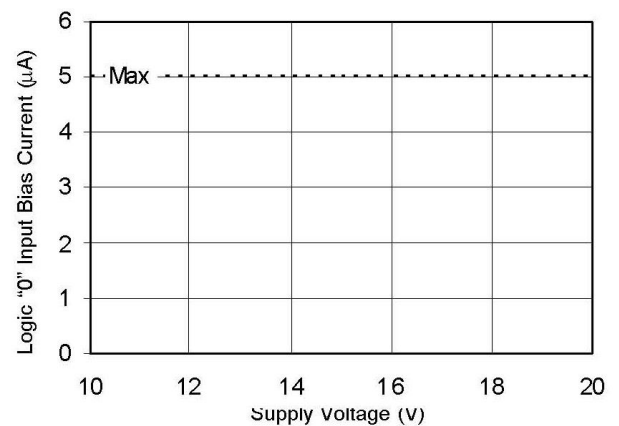
**Figure 13B. Offset Supply Current vs. Boost Voltage**

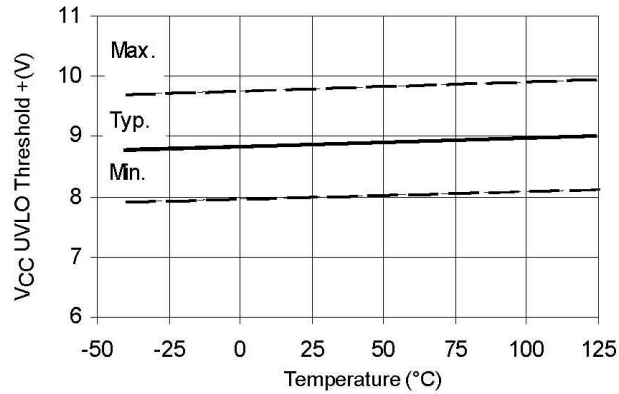


**Figure 14A.  $V_{BS}$  Supply Current vs. Temperature**

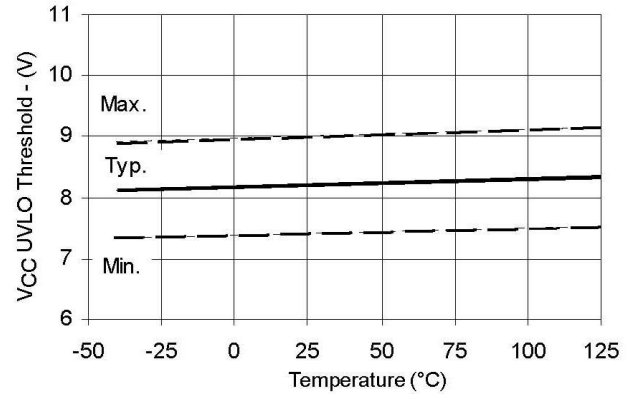


**Figure 14B.  $V_{BS}$  Supply Current vs. Supply Voltage**

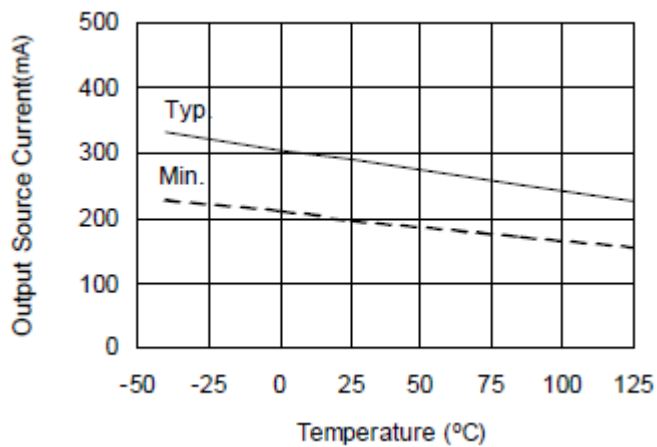

**Figure 15A.  $V_{CC}$  Supply Current vs. Temperature**

**Figure 15B.  $V_{CC}$  Supply Current vs. Supply Voltage**

**Figure 16A. Logic "1" Input Current vs. Temperature**

**Figure 16B. Logic "1" Input Current vs. Supply Voltage**

**Figure 17A. Logic "0" Input Bias Current vs. Temperature**

**Figure 17B. Logic "0" Input Bias Current vs. Supply Voltage**



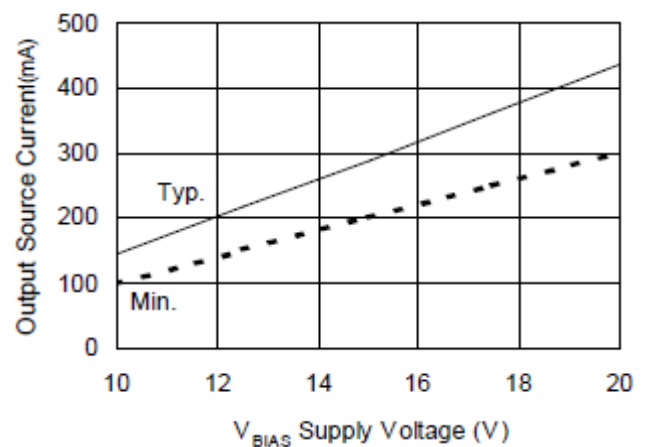
**Figure 18A.  $V_{CC}/V_{BS}$  Under-voltage Threshold(+) vs. Temperature**



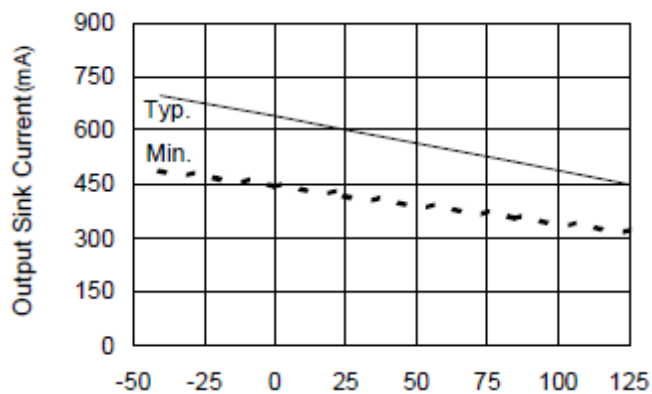
**Figure 18B.  $V_{CC}/V_{BS}$  Under-voltage Threshold(-) vs. Temperature**



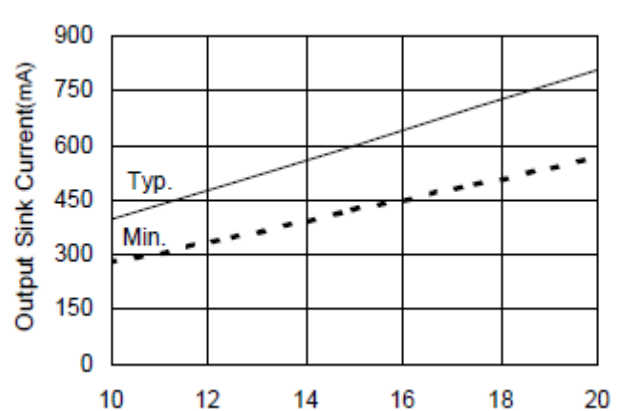
**Figure 19A. Output Source Current vs. Temperature**



**Figure 19B. Output Source Current vs. Supply Voltage**

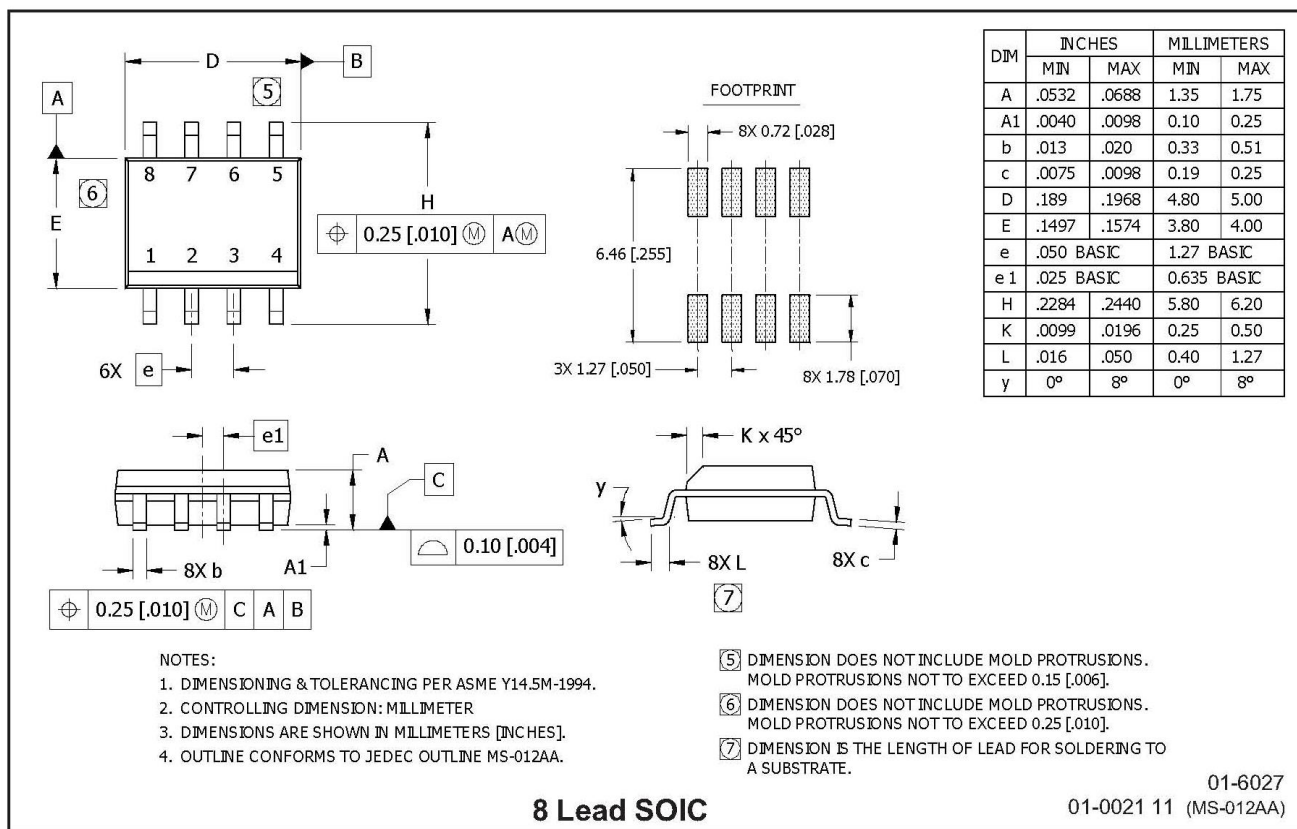


**Figure 20A. Output Sink Current vs. Temperature**

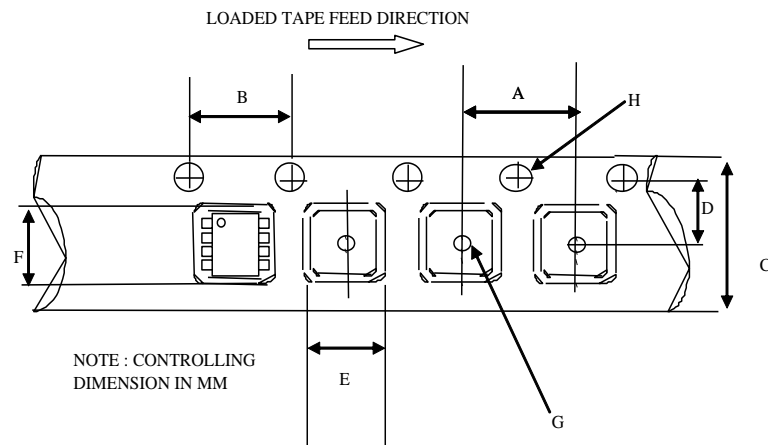


**Figure 20B. Output Sink Current vs. Supply Voltage**

## Package Details: 8-Lead SOIC

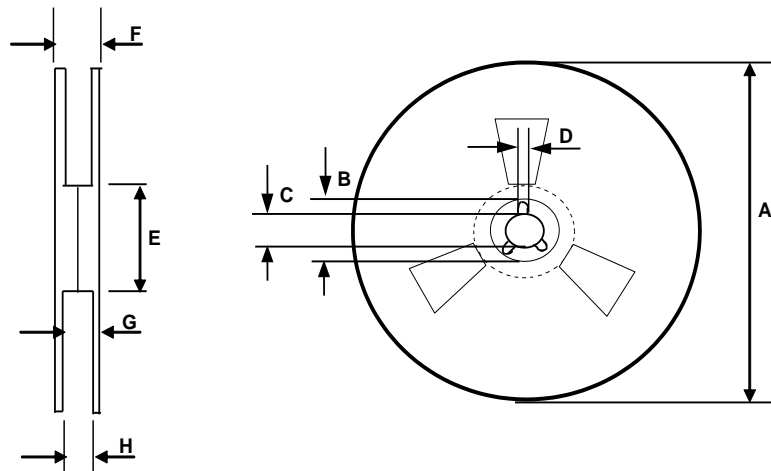


## Tape and Reel Details: 8-Lead SOIC



CARRIER TAPE DIMENSION FOR 8SOICN

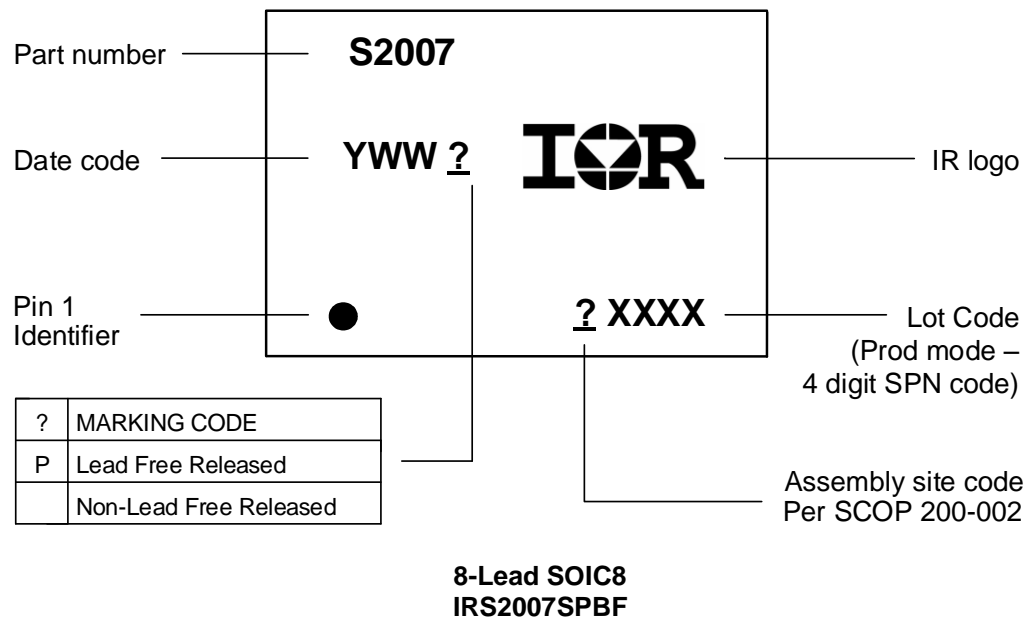
Code	Metric		Imperial	
	Min	Max	Min	Max
A	7.90	8.10	0.311	0.318
B	3.90	4.10	0.153	0.161
C	11.70	12.30	0.46	0.484
D	5.45	5.55	0.214	0.218
E	6.30	6.50	0.248	0.255
F	5.10	5.30	0.200	0.208
G	1.50	n/a	0.059	n/a
H	1.50	1.60	0.059	0.062



REEL DIMENSIONS FOR 8SOICN

Code	Metric		Imperial	
	Min	Max	Min	Max
A	329.60	330.25	12.976	13.001
B	20.95	21.45	0.824	0.844
C	12.80	13.20	0.503	0.519
D	1.95	2.45	0.767	0.096
E	98.00	102.00	3.858	4.015
F	n/a	18.40	n/a	0.724
G	14.50	17.10	0.570	0.673
H	12.40	14.40	0.488	0.566

## Part Marking Information



**Qualification Information<sup>†</sup>**

<b>Qualification Level</b>		<b>Industrial<sup>††</sup></b>	
		Comments: This family of ICs has passed JEDEC's Industrial qualification. Consumer qualification level is granted by extension of the higher Industrial level.	
<b>Moisture Sensitivity Level</b>		8 Lead SOIC	MSL2 <sup>†††</sup> , 260°C (per IPC/JEDEC J-STD-020)
<b>ESD</b>	Human Body Model	Class 2 (per JEDEC standard JESD22-A114)	
	Machine Model	Class A (per EIA/JEDEC standard EIA/JESD22-A115)	
<b>IC Latch-Up Test</b>		Class I (per JESD78)	
<b>RoHS Compliant</b>		Yes	

† Higher qualification ratings may be available should the user have such requirements. Please contact your Infineon sales representative for further information.

†† Higher MSL ratings may be available for the specific package types listed here. Please contact your Infineon sales representative for further information.

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